

**FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE**
**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

**ATTY DOCKET NO.**  
DN2001236

**SERIAL NO.**  
10/044,404

**APPLICANT (S)**  
David Ray Hubbell, Jr. et al.

**FILING DATE**  
January 11, 2002

**GROUP**  
1733

**RECEIVE**  
NOV 15 2002

**TC 1700**
**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date if Appropriate
jm	3 1 5 5 1 3 5	Nov. 3, 1964	H. Klenk	152	353	
jm	3 4 3 5 8 7 4	April 1, 1969	H. Mirtain et al.	152	352	
jm	3 7 6 5 4 6 8	Oct. 16, 1973	Verdier	152	352	
jm	3 9 8 0 1 1 8	Sept. 14, 1976	Kinas	152	209 R	
jm	4 7 6 3 7 0 8	Aug. 16, 1988	Takahashi et al.	152	209	
jm	4 8 3 0 0 7 7	May 16, 1989	Goto et al.	152	209	
jm	4 8 4 0 2 1 0	Jun. 20, 1989	Kukimoto	152	209	
jm	4 8 4 8 4 2 9	Jul. 18, 1989	Mezzanotte	152	209	
jm	4 8 7 7 0 7 2	Oct. 31, 1989	Fontaine	152	209	
jm	4 9 0 5 7 4 8	Mar. 6, 1990	Kukimoto et al.	152	209 R	
jm	5 2 0 5 9 7 8	Apr. 27, 1993	Ushikubo et al.			

**FOREIGN PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Country	Class	Sub-Class	Translation YES NO
jm	0 7 5 5 8 0 8	Jan. 29, 1997	Europe	B60C	3/06	
jm	8 2 0 8 8 4	Jan. 28, 1998	Europe	B60C	11/01	
jm	2 2 0 5 2 8 3	Apr. 21, 1988	Great Britain	B60C	3/06	
jm	6 1 2 8 2 1 02	Dec. 12, 1986	Japan	B60C	3/06	

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

Examiner Initial		
EXAMINER	Maki	DATE CONSIDERED: 11-26-03

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<b>FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use several sheets if necessary)	<b>ATTY DOCKET NO.</b> DN2001236	<b>SERIAL NO.</b>  <div style="text-align: center; font-size: 1.5em; font-weight: bold; transform: rotate(-5deg);">           RECEIVED            NOV 15 2002            TC 1700         </div>
<b>APPLICANT (S)</b> David Ray Hubbell, Jr.		<b>FILING DATE</b>
<div style="border: 1px solid black; border-radius: 50%; width: 100px; height: 100px; display: flex; align-items: center; justify-content: center; margin: 0 auto;"> <div style="text-align: center;">             OIPE JC176              NOV 13 2002              PATENT &amp; TRADEMARK OFFICE           </div> </div>		<b>GROUP</b>

### U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date if Appropriate
jm	5 3 0 1 7 2 8	Apr. 12, 1994	Brown, Jr. et al.	152	209R	
jm	5 5 9 1 2 8 2	Jan. 7, 1997	Weber et al.	152	456	
jm	5 6 2 0 5 3 8	Apr. 15, 1997	Oshima	152	209	
jm	5 7 3 5 9 7 9	Apr. 7, 1998	Secondari	152	209 A	
jm	5 9 7 1 0 4 8	Oct. 26, 1999	Ashmore et al.	152	209 RR	

### FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Sub-Class	Translation YES NO
jm	8 1 0 9 5 5	Apr. 22, 1969	Canada	152	89	X

### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner Initial	
EXAMINER	Maki      DATE CONSIDERED: 11-26-03

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.